

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10828281	WANG ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Hernandez, Josiah	2626

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
			JH

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST search: US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM; see search print out	06/23/2008	JH
Searched NPL: google scholar, IEEE	06/23/2008	JH

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
704	10,5,7,4	06/23/2008	JH
707	102,4,1,5,10,3	06/23/2008	JH